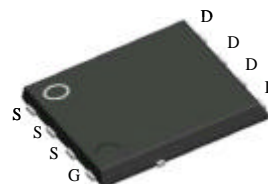


## N-Channel Enhancement Mode MOSFET

### Features

- 30V/70A,  
 $R_{DS(ON)} = 4.5m\Omega$  (typ.) @  $V_{GS} = 10V$   
 $R_{DS(ON)} = 6m\Omega$  (typ.) @  $V_{GS} = 4.5V$
- Super High Dense Cell Design
- Avalanche Rated
- Reliable and Rugged
- Lead Free Available (RoHS Compliant)

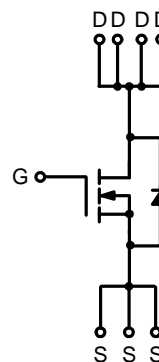
### Pin Description



Top View of KPAK

### Applications

- Power Management in Notebook Computer, or Desktop Computer.



N-Channel MOSFET

### Ordering and Marking Information

<p>APM4354 <span style="font-family: monospace;">□□-□□□</span></p> <div style="margin-left: 20px;"> <p>└─ Lead Free Code</p> <p>└─ Handling Code</p> <p>└─ Temp. Range</p> <p>└─ Package Code</p> </div>	<p>Package Code                  KP : KPAK</p> <p>Operating Junction Temp. Range                  C : -55 to 150 °C</p> <p>Handling Code                  TU : Tube    TR : Tape &amp; Reel</p> <p>Lead Free Code                  L : Lead Free Device</p>
<p>APM4354 KP : <span style="border: 1px solid black; padding: 2px; display: inline-block; text-align: center;">                       APM4354                      XXXXX                 </span></p>	<p>XXXXX - Date Code</p>

Note: ANPEC lead-free products contain molding compounds/die attach materials and 100% matte in plate termination finish; which are fully compliant with RoHS and compatible with both SnPb and lead-free soldering operations. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J STD-020C for MSL classification at lead-free peak reflow temperature.

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

## Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Unit	
<b>Common Ratings</b> ( $T_A=25^\circ\text{C}$ Unless Otherwise Noted)				
$V_{DSS}$	Drain-Source Voltage	30	V	
$V_{GSS}$	Gate-Source Voltage	$\pm 20$		
$T_J$	Maximum Junction Temperature	150	$^\circ\text{C}$	
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$	
$I_S$	Diode Continuous Forward Current	$T_C=25^\circ\text{C}$	50	A
$I_{DP}$	300 $\mu\text{s}$ Pulse Drain Current Tested	$T_C=25^\circ\text{C}$	150	A
		$T_C=100^\circ\text{C}$	90	
<b>Mounted on Large Heat Sink</b>				
$I_D$	Continuous Drain Current	$T_C=25^\circ\text{C}$	70	A
		$T_C=100^\circ\text{C}$	40	
$P_D$	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	50	W
		$T_C=100^\circ\text{C}$	20	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	2.5	$^\circ\text{C/W}$	
<b>Mounted on PCB of 1in<sup>2</sup> pad area</b>				
$I_D$	Continuous Drain Current	$T_A=25^\circ\text{C}$	17	A
		$T_A=100^\circ\text{C}$	11	
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	2.5	W
		$T_A=100^\circ\text{C}$	1	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	50	$^\circ\text{C/W}$	
<b>Mounted on PCB of Minimum Footprint</b>				
$I_D$	Continuous Drain Current	$T_A=25^\circ\text{C}$	14	A
		$T_A=100^\circ\text{C}$	8	
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	1.5	W
		$T_A=100^\circ\text{C}$	0.5	
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	75	$^\circ\text{C/W}$	

## Electrical Characteristics ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

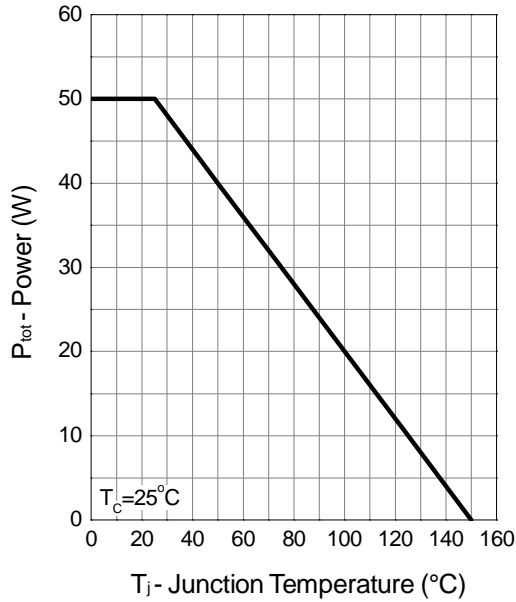
Symbol	Parameter	Test Condition	APM4354KP			Unit
			Min.	Typ.	Max.	
<b>Static Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_{DS}=250\mu A$	30			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=24V, V_{GS}=0V$ $T_J=85^\circ\text{C}$			1 30	$\mu A$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{DS}=250\mu A$	1.3	1.8	2.5	V
$I_{GSS}$	Gate Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$			$\pm 100$	nA
$R_{DS(ON)}^a$	Drain-Source On-state Resistance	$V_{GS}=10V, I_{DS}=30A$		4.5	5.5	m $\Omega$
		$V_{GS}=4.5V, I_{DS}=20A$		6	8	
<b>Diode Characteristics</b>						
$V_{SD}^a$	Diode Forward Voltage	$I_{SD}=20A, V_{GS}=0V$		0.75	1.1	V
$t_{rr}$	Reverse Recovery Time	$I_{DS}=20A, di_{SD}/dt=100A/\mu s$		36		ns
$Q_{rr}$	Reverse Recovery Charge			29		nC
<b>Gate Charge Characteristics <sup>b</sup></b>						
$Q_g$	Total Gate Charge	$V_{DS}=15V, V_{GS}=10V,$ $I_{DS}=30A$		63	88	nC
$Q_{gs}$	Gate-Source Charge			10		
$Q_{gd}$	Gate-Drain Charge			19		
<b>Dynamic Characteristics <sup>b</sup></b>						
$R_G$	Gate Resistance	$V_{GS}=0V, V_{DS}=0V, F=1\text{MHz}$		1		$\Omega$
$C_{iss}$	Input Capacitance	$V_{GS}=0V,$ $V_{DS}=15V,$ Frequency=1.0MHz		3350		pF
$C_{oss}$	Output Capacitance			425		
$C_{riss}$	Reverse Transfer Capacitance			330		
$t_{d(ON)}$	Turn-on Delay Time	$V_{DD}=15V, R_L=15\Omega,$ $I_{DS}=1A, V_{GEN}=10V,$ $R_G=6\Omega$		24	44	ns
$t_r$	Turn-on Rise Time			23	42	
$t_{d(OFF)}$	Turn-off Delay Time			73	132	
$t_f$	Turn-off Fall Time			27	50	

Note :

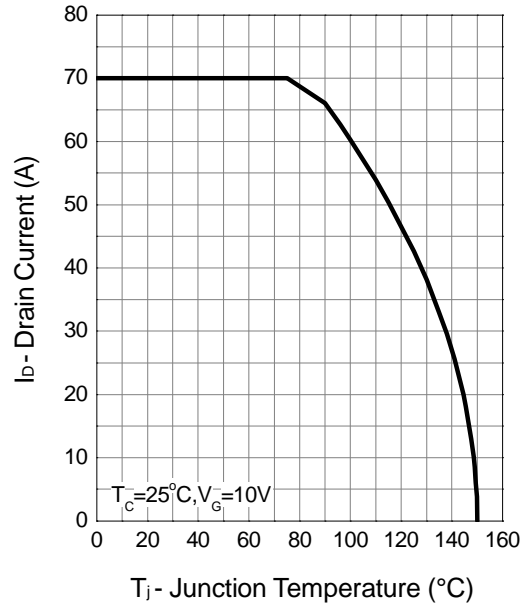
- a : Pulse test ; pulse width $\leq 300\mu s$ , duty cycle $\leq 2\%$ .
- b : Guaranteed by design, not subject to production testing.

## Typical Characteristics

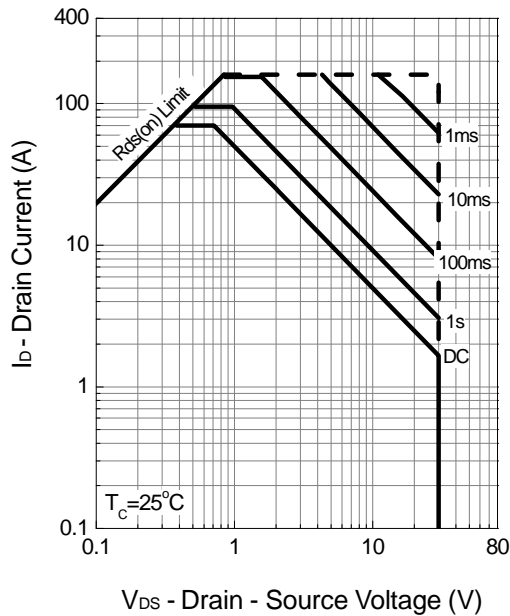
Power Dissipation



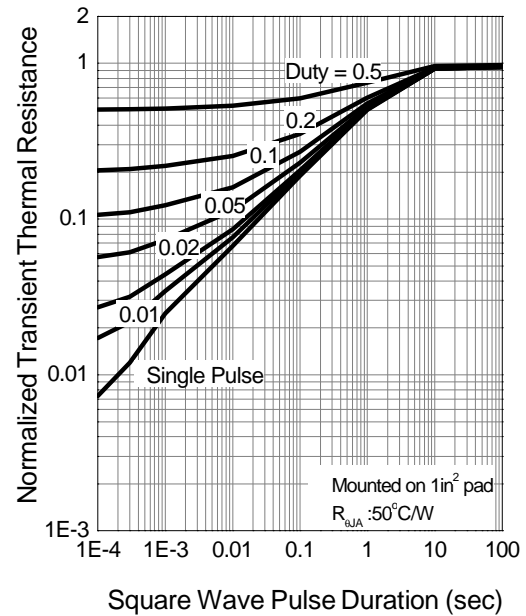
Drain Current



Safe Operation Area

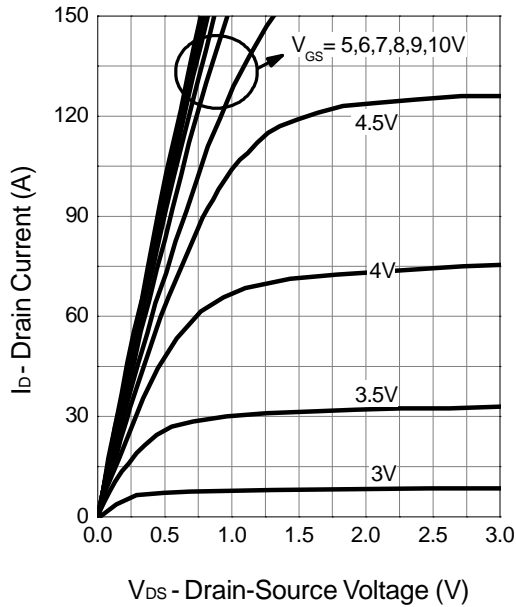


Thermal Transient Impedance

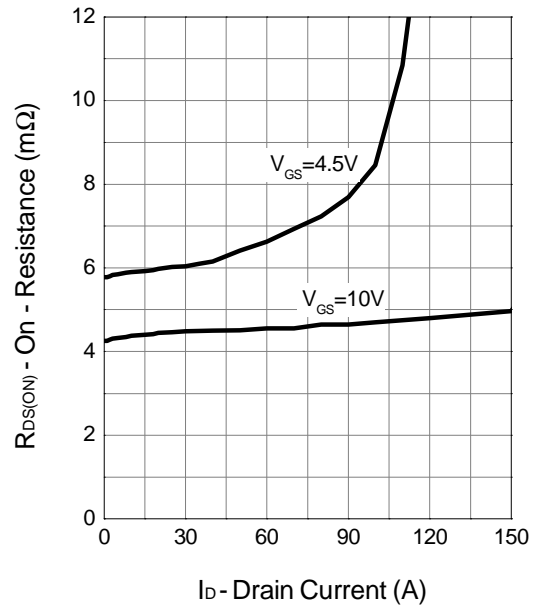


Typical Characteristics (Cont.)

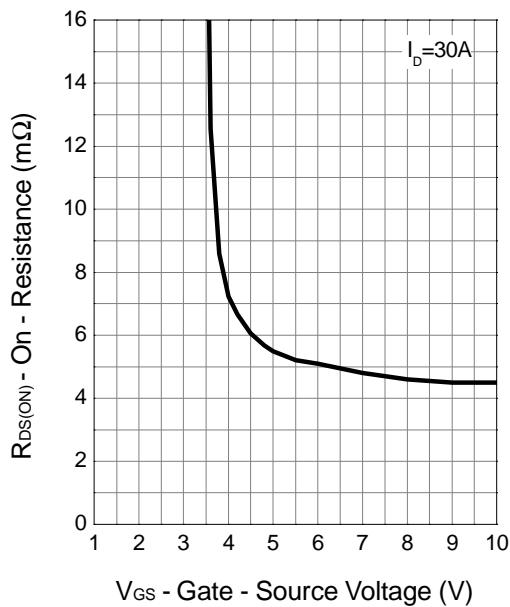
Output Characteristics



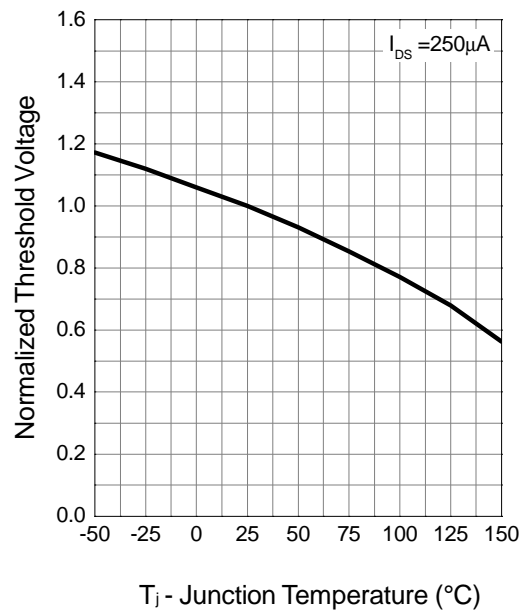
Drain-Source On Resistance



Gate-Source On Resistance

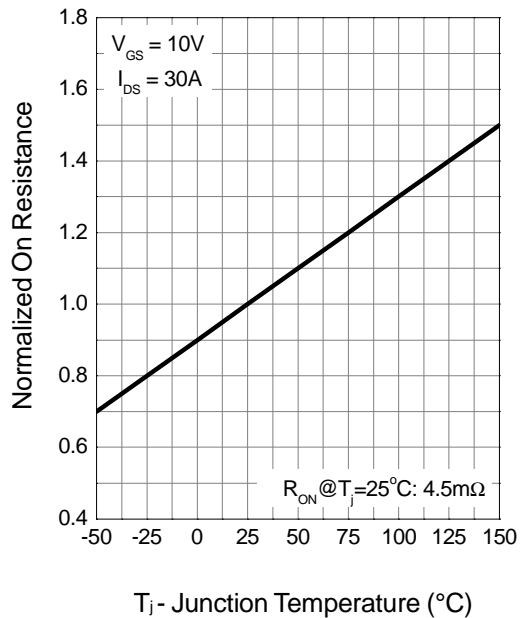


Gate Threshold Voltage

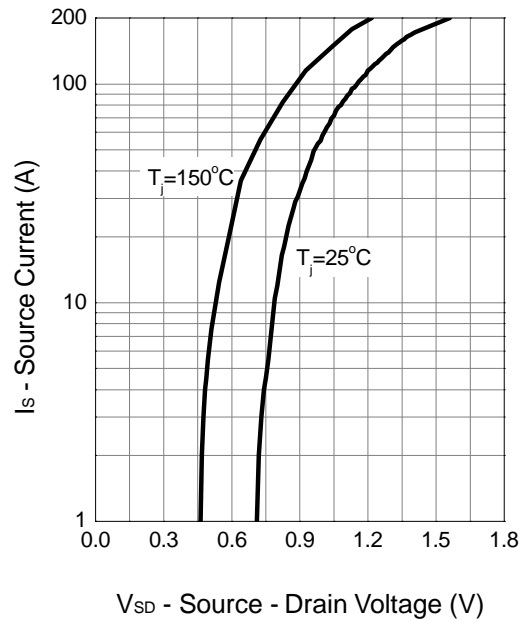


Typical Characteristics (Cont.)

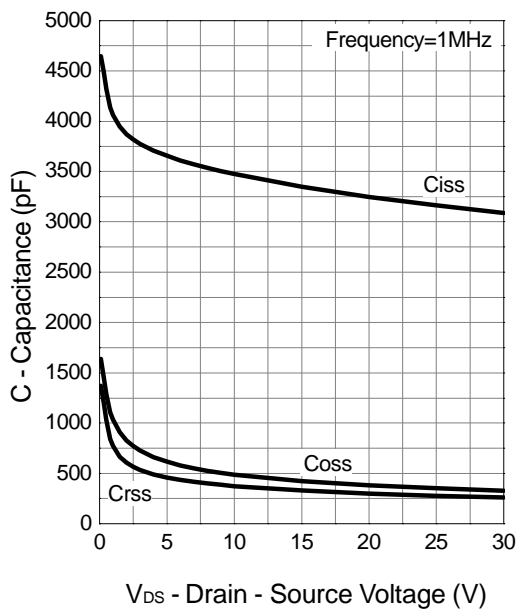
Drain-Source On Resistance



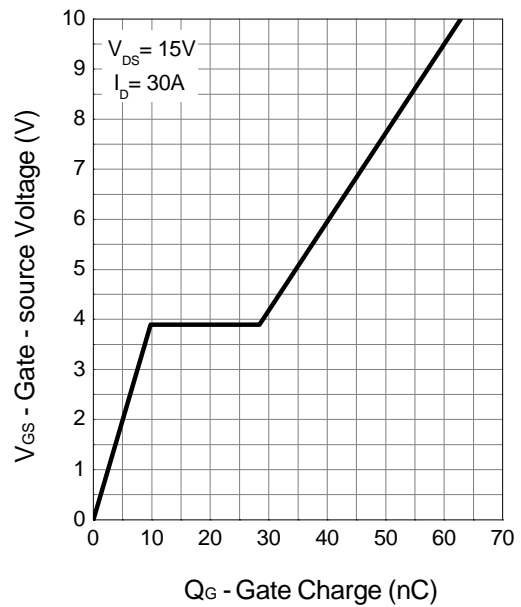
Source-Drain Diode Forward



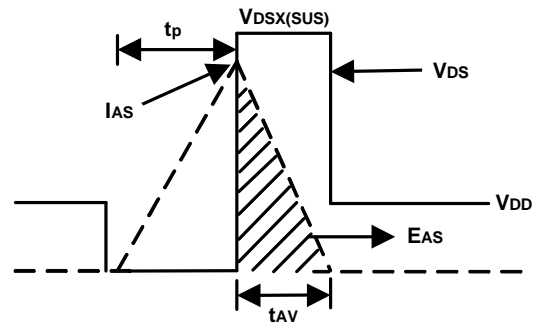
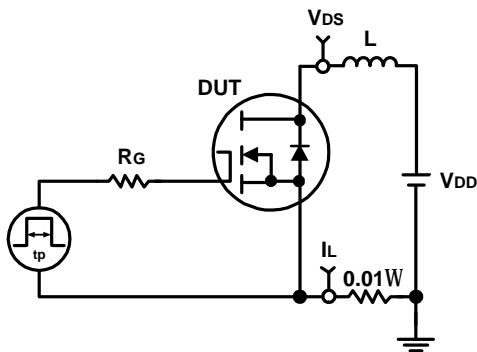
Capacitance



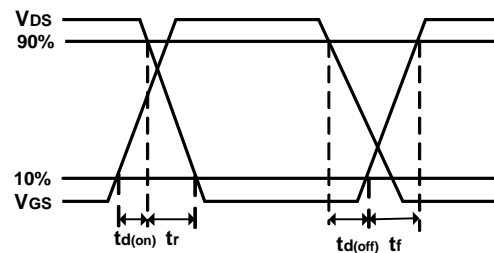
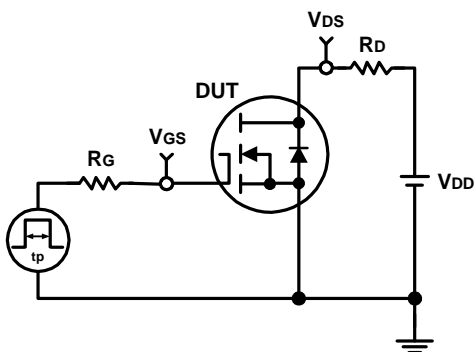
Gate Charge



## Avalanche Test Circuit and Waveforms

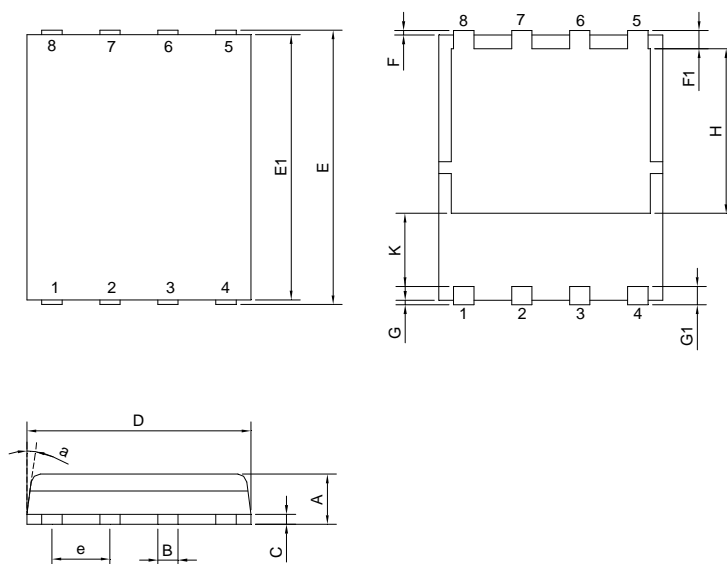


## Switching Time Test Circuit and Waveforms



## Packaging Information

KPAK (Reference JEDEC Registration MS-012)



Dim	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	1.00	1.20	0.039	0.047
B	0.38	0.51	0.015	0.020
C	0.19	0.25	0.007	0.010
D	4.80	5.00	0.189	0.197
E	5.90	6.10	0.232	0.240
E1	5.696	5.796	0.224	0.228
e	1.27 BSC		0.050 BSC	
F	0.052	0.152	0.002	0.006
F1	0.352	0.452	0.014	0.018
G	0.052	0.152	0.002	0.006
G1	0.352	0.452	0.014	0.018
H	3.491	3.691	0.137	0.145
K	1.60	-	0.063	-
a	0°	12°	0°	12°

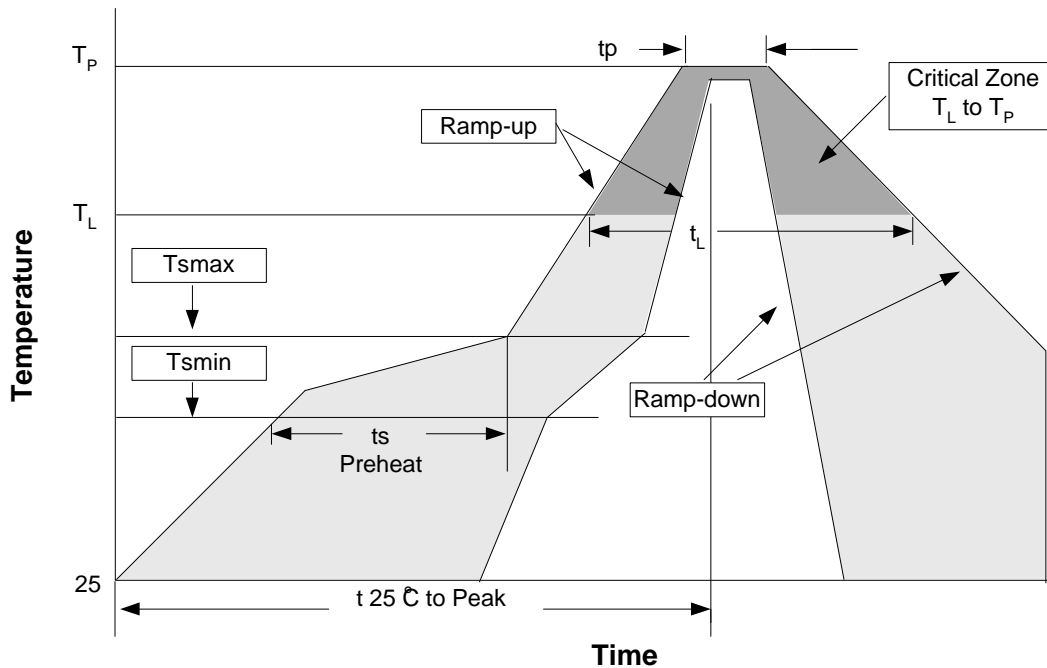
## Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : 90/10 or 63/37 SnPb,100%Sn).
Lead Solderability	Meets EIA Specification RS186-91, ANSI/J-STD-002 Category 3.



## Reflow Condition

(IR/Convection or VPR Reflow)



## Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly		Pb-Free Assembly	
	Large Body	Small Body	Large Body	Small Body
Average ramp-up rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/second max.		3°C/second max.	
Preheat	100°C		150°C	
- Temperature Min (T <sub>smin</sub> )	150°C		200°C	
- Temperature Max (T <sub>smax</sub> )	60-120 seconds		60-180 seconds	
- Time (min to max) (t <sub>s</sub> )				
T <sub>smax</sub> to T <sub>L</sub>			3°C/second max	
- Ramp-up Rate				
Time maintained above:	183°C		217°C	
- Temperature (T <sub>L</sub> )	60-150 seconds		60-150 seconds	
- Time (t <sub>L</sub> )				
Peak Temperature (T <sub>p</sub> )	225 +0/-5°C	240 +0/-5°C	245 +0/-5°C	250 +0/-5°C
Time within 5°C of actual Peak Temperature (t <sub>p</sub> )	10-30 seconds	10-30 seconds	10-30 seconds	20-40 seconds
Ramp-down Rate	6°C/second max.		6°C/second max.	
Time 25°C to Peak Temperature	6 minutes max.		8 minutes max.	

Notes: All temperatures refer to topside of the package .Measured on the body surface.

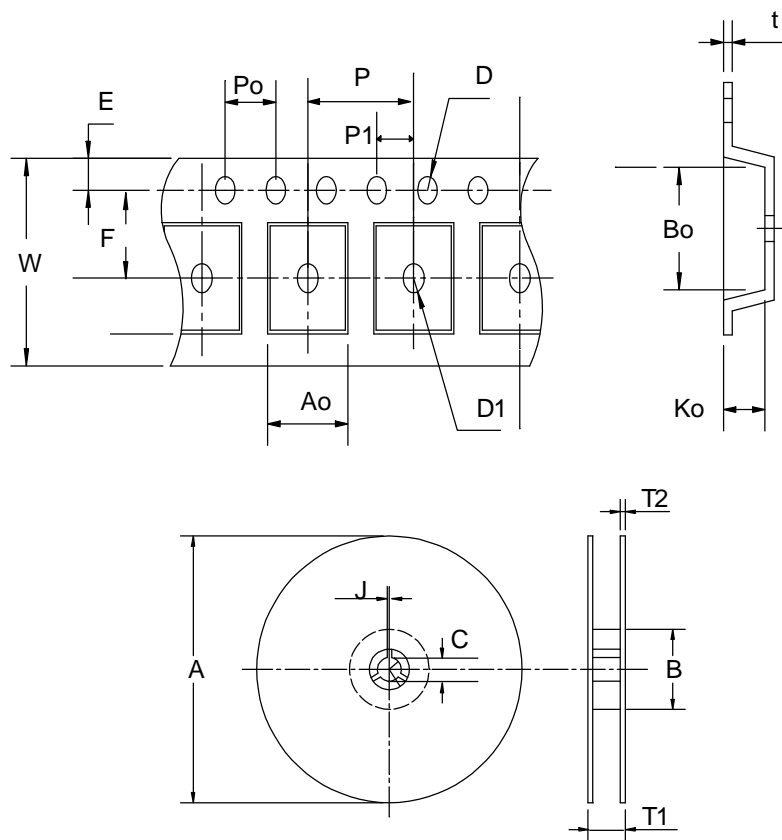
## Package Reflow Conditions

pkg. thickness $\geq$ 2.5mm and all bags	pkg. thickness < 2.5mm and pkg. volume $\geq$ 350mm <sup>3</sup>	pkg. thickness < 2.5mm and pkg. volume < 350mm <sup>3</sup>
Convection 220 +5/-0 °C		Convection 235 +5/-0 °C
VPR 215-219 °C		VPR 235 +5/-0 °C
IR/Convection 220 +5/-0 °C		IR/Convection 220 +5/-0 °C

## Reliability test program

Test Item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 SEC
HOLT	MIL-STD 883D-1005.7	1000 Hrs Bias @ 125°C
PCT	JESD-22-B, A102	168 Hrs, 100% RH, 121°C
TST	MIL-STD 883D-1011.9	-65°C ~ 150°C, 200 Cycles

## Carrier Tape & Reel Dimensions



## Carrier Tape & Reel Dimensions(Cont.)

Application	A	B	C	J	T1	T2	W	P	E
SOP- 8	330±1	62+1.5	12.75+ 0.15	2±0.5	12.4±0.2	2±0.2	12±0. 3	8±0.1	1.75±0.1
	F	D	D1	Po	P1	Ao	Bo	Ko	t
	5.5±1	1.55+0.1	1.55+0.25	4.0±0.1	2.0±0.1	6.4±0.1	5.2±0. 1	2.1±0.1	0.3±0.013

## Cover Tape Dimensions

Application	Carrier Width	Cover Tape Width	Devices Per Reel
SOP-8	12	9.3	2500

## Customer Service

### Anpec Electronics Corp.

Head Office :

No.6, Dusing 1st Road, SBIP,

Hsin-Chu, Taiwan, R.O.C.

Tel : 886-3-5642000

Fax : 886-3-5642050

Taipei Branch :

7F, No. 137, Lane 235, Pac Chiao Rd.,

Hsin Tien City, Taipei Hsien, Taiwan, R. O. C.

Tel : 886-2-89191368

Fax : 886-2-89191369